Product data sheet

1. General description

Dual ultrafast power diode in a SOT78 (TO-220AB) plastic package

2. Features and benefits

- Ultra low leakage current
- High junction temperature up to 175 °C
- Low on-state loss
- Fast switching
- Soft recovery characteristic minimizes power consuming oscillations
- High reverse surge capability
- High thermal cycling performance
- Low thermal resistance

3. Applications

Home appliance power supply

4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|------------------------|-------------------------------------|--|--|-----|------|------|------|
| V_{RRM} | repetitive peak reverse voltage | | | - | - | 200 | V |
| I _{O(AV)} | average output current | δ = 0.5; T _{mb} ≤ 149 °C; Square-ware pulse | | - | - | 20 | Α |
| I _{FSM} | non-repetitive peak forward current | $T_{j(init)}$ = 25 °C; t_p = 8.3 ms; SIN; per diode; Fig. 4 | | - | - | 137 | А |
| I _{RRM} | repetitive peak reverse current | t_p = 2 μ s; δ = 0.001; per diode | | - | - | 0.2 | Α |
| V _{ESD} | electrostatic discharge voltage | HBM; C = 250 pF; R = 1.5 k Ω ; all pins | | - | - | 8 | kV |
| Dynamic char | acteristics | | | | | | |
| t _{rr} | reverse recovery time | $I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/µs}$; $T_j = 25 \text{ °C}$; Fig. 7 | | - | 18 | 25 | ns |
| Static characteristics | | | | | | | |
| V _F | forward voltage | I _F = 8 A; T _j = 150 °C; <u>Fig. 6</u> | | - | 0.76 | 0.85 | V |





5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-------------|------------------------|----------------|
| 1 | A1 | anode 1 | mb | A1 |
| 2 | K | cathode | ├ ○ ┤ | K K |
| 3 | A2 | anode 2 | 1 2 3 TO-220AB (SOT78) | sym125 |

6. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|-------------|----------|--|---------|
| | Name | Description | Version |
| BYV32E-200P | TO-220AB | plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB | SOT78 |

7. Marking

Table 4. Marking codes

| Type number | Marking code |
|-------------|--------------|
| BYV32E-200P | BYV32E-200P |

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|--------------------|-------------------------------------|---|-----|-----|------|
| V_{RRM} | repetitive peak reverse voltage | | - | 200 | V |
| V_{RWM} | crest working reverse voltage | | - | 200 | V |
| V _R | reverse voltage | DC | - | 200 | V |
| I _{F(AV)} | average forward current | \bar{o} = 0.5; $T_{mb} \le$ 149 °C; Square-ware pulse; Fig. 1; Fig. 2; Fig. 3 | - | 10 | A |
| I _{O(AV)} | average output current | \bar{o} = 0.5; T _{mb} ≤ 149 °C; Square-ware pulse | - | 20 | A |
| I _{FSM} | non-repetitive peak forward current | SIN; $t_p = 10 \text{ ms}$; $T_{j(init)} = 25 \text{ °C}$; per diode; Fig. 4 | - | 125 | A |
| | | SIN; t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; per diode; Fig. 4 | - | 137 | A |
| I _{RRM} | repetitive peak reverse current | δ = 0.001; t_p = 2 μ s; per diode | - | 0.2 | Α |
| I _{RSM} | non-repetitive peak reverse current | t _p = 100 μs; per diode | - | 0.2 | A |
| T _{stg} | storage temperature | | -65 | 175 | °C |
| Tj | junction temperature | | - | 175 | °C |
| V _{ESD} | electrostatic discharge voltage | HBM; C = 250 pF; R = 1.5 kΩ; all pins | - | 8 | kV |

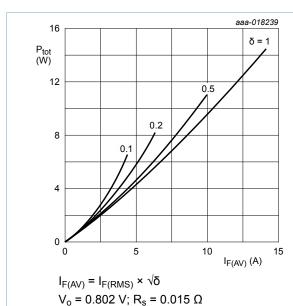


Fig. 1. Forward power dissipation as a function of average forward current; square waveform; maximum values

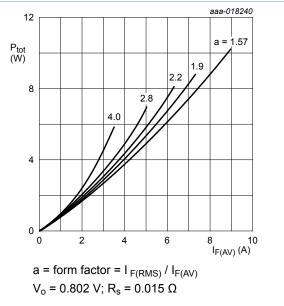


Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values

BYV32E-200P

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Dual ultrafast power diode

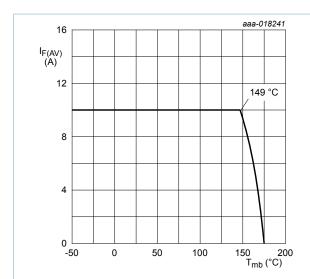


Fig. 3. Forward current as a function of mounting base temperature; maximum values

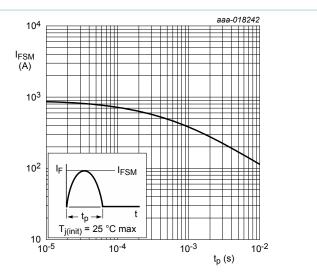


Fig. 4. Non-repetitive peak forward current as a function of pulse width; sinusoidal waveform; maximum values

9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---|--|-----|-----|-----|------|
| R _{th(j-mb)} | thermal resistance from junction to | with heatsink compound; both diodes conducting | - | - | 1.4 | K/W |
| | mounting base | with heatsink compound; per diode; Fig. 5 | - | - | 2.4 | K/W |
| R _{th(j-a)} | thermal resistance from junction to ambient | in free air | - | 60 | - | K/W |

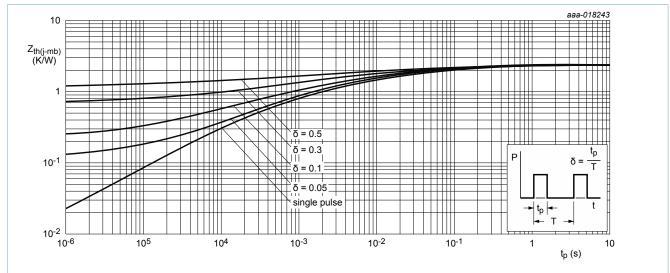


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Characteristics

Table 7. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------|-------------------------------|---|-----|------|------|------|
| Dynamic cl | haracteristics | | | | | |
| Q _r | recovered charge | $I_F = 2 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 20 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; Fig. 7 | - | 13.5 | - | nC |
| | | $I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; Fig. 7 | - | 14.5 | - | nC |
| t _{rr} | reverse recovery time | $I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; Fig. 7 | - | 18 | 25 | ns |
| I _{RM} | peak reverse recovery current | $I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A}/\mu\text{s}$; $T_j = 25 ^{\circ}\text{C}$ | - | 1.7 | - | A |
| Static char | acteristics | | | | | |
| V _F | forward voltage | I _F = 20 A; T _j = 25 °C; <u>Fig. 6</u> | - | 1.06 | 1.15 | V |
| | | I _F = 8 A; T _j = 150 °C; <u>Fig. 6</u> | - | 0.76 | 0.85 | V |
| | | I _F = 10 A; T _j = 25 °C; <u>Fig. 6</u> | - | 0.95 | - | V |
| I _R | reverse current | V _R = 200 V; T _j = 25 °C | - | 0.3 | 5 | μA |
| | | V _R = 200 V; T _j = 150 °C | - | 70 | 250 | μA |

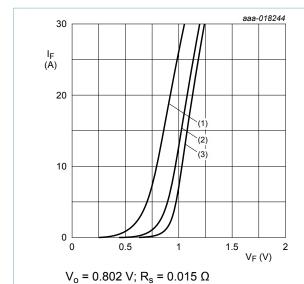


Fig. 6. Forward current as a function of forward voltage

(1) T_j = 150 °C; typical values (2) T_j = 150 °C; maximum values (3) T_j = 25 °C; maximum values

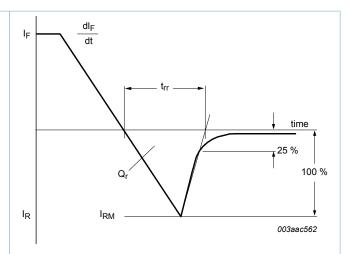
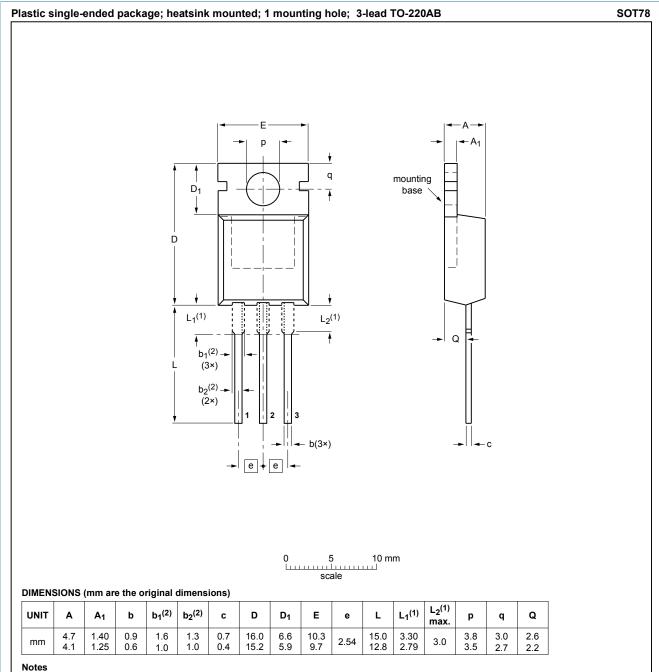


Fig. 7. Reverse recovery definitions; ramp recovery

11. Package outline



- 1. Lead shoulder designs may vary.
- Dimension includes excess dambar.

| OUTLINE | | REFER | ENCES | EUROPEAN | ISSUE DATE | |
|---------|-----|-----------------|-------|------------|---------------------------------|--|
| VERSION | IEC | JEDEC | JEITA | PROJECTION | ISSUE DATE | |
| SOT78 | | 3-lead TO-220AB | SC-46 | | 08-04-23 08-06-13 | |

Fig. 8. Package outline TO-220AB (SOT78)

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13. Contents

| 1 | General description | 1 |
|------|-------------------------|---|
| 2 | Features and benefits | 1 |
| 3 | Applications | 1 |
| 4 | Quick reference data | 1 |
| 5 | Pinning information | 2 |
| 6 | Ordering information | 2 |
| 7 | Marking | 2 |
| 8 | Limiting values | 3 |
| 9 | Thermal characteristics | 5 |
| 10 | Characteristics | 6 |
| 11 | Package outline | 7 |
| 12 | Legal information | 8 |
| 12.1 | Data sheet status | 8 |
| 12.2 | Definitions | 8 |
| 12.3 | Disclaimers | 8 |
| 12.4 | Trademarks | 9 |

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